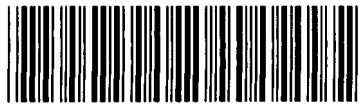


<b>Search Notes</b>  	<b>Application/Control No.</b>  10823529	<b>Applicant(s)/Patent Under Reexamination</b>  JIN ET AL.
	<b>Examiner</b>  Lam, David	<b>Art Unit</b>  2827

SEARCHED			
Class	Subclass	Date	Examiner
365	154, 149, 205	5/20/07	DL
257	903, 292, 296, E21.661, E27.098	5/20/07	DL
438	154, 239, 396, FOR. 430	5/20/07	DL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (365/\$.ccls.; 257/\$.ccls.; 438/\$.ccls.) text search - see history printout.	5/20/07	DL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner